

**Notice of References Cited**

Application/Control No.

10/532,206

Applicant(s)/Patent Under  
Reexamination  
ANNA ET AL.

Examiner

David Buttner

Art Unit

1712

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0059060	03-2004	Chino et al.	525/190
*	B	US-6,559,263	05-2003	Benecke et al.	528/45
*	C	US-5,231,137	07-1993	Fisher et al.	525/176
*	D	US-4,388,451	06-1983	Culbertson et al.	526/271
*	E	US-4,182,803	01-1980	Kanagawa et al.	526/313
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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